

<b>Notice of References Cited</b>	Application/Control No. 10/032,845	Applicant(s)/Patent Under Reexamination SHUDO ET AL.	
	Examiner David T. Fidei	Art Unit 3728	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,784,885	11-1988	Carespodì, Dennis L.	428/36.8
	B	US-5,154,789 A	10-1992	Ossian, William F.	156/229
	C	US-5,273,797 A	12-1993	Hazelton et al.	428/34.7
	D	US-5,423,737 A	06-1995	Cartmell et al.	602/57
	E	US-5,505,306 A	04-1996	Akemi et al.	206/438
	F	US-5,700,091	12-1997	Tanaka et al.	383/63
	G	US-6,127,024 A	10-2000	Weiss et al.	428/204
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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